

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.103123		APPLICATION NO. 10/553,660		
			APPLICANT Manabu Komatsu et al.				
			FILING DATE December 22, 2004		GROUP 1743		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,365,563	11/15/94	Kira et al.	378	48	
		6,579,139 B1	06/17/03	Mishima et al.	445	24	
		6,476,215 B1	11/05/02	Okamoto et al.	536	25.3	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
JP		2000-251665	09/14/00	Japan			Abstract
JP		11-187900	07/13/99	Japan			Abstract
JP		4-361055	12/14/92	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		Paolo Lazzari et al., "Use of Spin-Coated TXRF Reference Samples for ToF-SIMS Metal Contaminant Quantification on Silicon Wafers," 29 Surf. Interface Anal. 798-803 (2000).					
EXAMINER <i>/Brian Gordon/</i>				DATE CONSIDERED			10/09/2008

***EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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